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### INFORMATION DISCLOSURE STATEMENT BY APPLICANT

|                             |                      |
|-----------------------------|----------------------|
| Applicant: Raymond H. Kraft |                      |
| Appln. No.: 10/800,421      |                      |
| Filing Date: March 12, 2004 |                      |
| Examiner:                   | Group Art Unit: 2857 |

Date: October 13, 2004

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#### U.S. PATENT DOCUMENTS

| Examiner's<br>Initials* | Document<br>Number | Date<br>MM/YYYY | Name<br>(Family Name of First Inventor) | Class | Sub<br>Class | Filing<br>Date<br>(if appropriate) |
|-------------------------|--------------------|-----------------|---|-------|--------------|------------------------------------|
|                         | AR                 |                 |   |       |              |                                    |
|                         | BR                 |                 |   |       |              |                                    |
|                         | CR                 |                 |   |       |              |                                    |
|                         | DR                 |                 |   |       |              |                                    |

#### FOREIGN PATENT DOCUMENTS

|     |    | Document<br>Number | Date<br>MM/YYYY | Country | Inventor Name | English<br>Abstract |    | Translation<br>Readily<br>Available |    |
|-----|----|--------------------|-----------------|---------|---------------|---------------------|----|-------------------------------------|----|
|     |    |                    |                 |         |               | Enclosed            | No | Enclose                             | No |
| JLR | ER | EP 1061381 A2      | 12/2000         | EPO     | Strom         | X                   |    | X                                   |    |
|     | FR |                    |                 |         |               |                     |    |                                     |    |
|     | GR |                    |                 |         |               |                     |    |                                     |    |
|     | HR |                    |                 |         |               |                     |    |                                     |    |
|     | IR |                    |                 |         |               |                     |    |                                     |    |
|     | JR |                    |                 |         |               |                     |    |                                     |    |

#### OTHER (Including in this order: Author, Title, Periodical Name, Date, Pertinent Pages, etc.)

|     |    |   |   |  |   |  |
|-----|----|---|---|--|---|--|
| JLR | KR | WANG, Y.; Lawrence H. Staib; "Physical Model-based non-rigid registration incorporating statistical shape information" Medical Image Analysis, Vol. 4, No. 1, 2000, pp. 7-20  | X |  | X |  |
| JLR | LR | BESL, Paul J., and Neil D. McKay, "A method for registration of 3-D shapes" IEEE Transactions on Pattern Analysis and Machine Intelligence, IEEE Inc., New York, U.S., Vol. 14, No. 2, February 1, 1992, Opp. 239-256 | X |  | X |  |
| JLR | MR | RANGARAJAN, Anand, Hali Chui and Eric Mjolsness, "A new distance for non-rigid image matching" 1999, Berlin, Germany, pp. 237-252   | X |  | X |  |
| JLR | NR | CACHIER, Pascal, and Xavier Pennec "3D Non-Rigid Registration by Gradient Descent on a Gaussian-Windowed Similarity Measure Using Convolutions" IEEE Comput. Soc. U.S.A., June 2000, pp. 182-189                      | X |  | X |  |
|     | OR |   |   |  |   |  |
|     | PR |   |   |  |   |  |

Examiner: *[Signature]* Date Considered: 6/10/05

\*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.